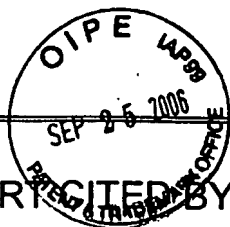


APPLN. SERIAL NO.  
New U.S. Patent  
Application 10/150

**GROUP**  
**Unassigned**

## 05/22/2007

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SHEET 1 OF 1

**LIST OF ART CITED BY APPLICANT**  
(PTO-1449)ATTY. DOCKET NO.  
IK-0096APPLN. SERIAL NO.  
10/508,976APPLICANT(S)  
Young-Nam KIM, Jee-Suck LEE, Ju-Hwan  
KIM, Seon-II YU, Seon-Kyu KIM and Kun-Jun  
SEOKFILING DATE  
September 24, 2004GROUP  
3637**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

**U.S. PATENT APPLICATION PUBLICATIONS**

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

**U.S. PATENT APPLICATIONS**

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

**FOREIGN PATENT DOCUMENTS**

EXAMINER'S INITIALS	PATENT/PUB NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/MKK/	100213143	05-13-1999	KOREA			ABST	
/MKK/	SH0057-125992	08-05-1982	JAPAN			ABST	

**OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)**


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/Mart K. Kuhn/DATE CONSIDERED  
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